

Notice of References Cited

Application/Control No.

10/522,126

Applicant(s)/Patent Under
Reexamination
MARUYAMA ET AL.

Examiner

SATH V. PERUNGAVOOR

Art Unit

2624

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,488,719 A	01-1996	Kaplan et al.	707/100
*	B	US-5,933,525 A	08-1999	Makhoul et al.	382/186
*	C	US-6,269,260 B1	07-2001	Shin et al.	455/550.1
*	D	US-2001/0013012 A1	08-2001	Hanaoka et al.	705/14
*	E	US-2001/0027409 A1	10-2001	Sasaki et al.	705/10
*	F	US-6,351,634 B1	02-2002	Shin, Jang-Ki	455/410
*	G	US-2002/0058536 A1	05-2002	Horii et al.	455/566
*	H	US-2002/0056576 A1	05-2002	Ericson, Petter	178/18.01
*	I	US-2002/0131636 A1	09-2002	Hou, Darwin	382/181
*	J	US-6,487,421 B2	11-2002	Hess et al.	455/550.1
*	K	US-2003/0044068 A1	03-2003	Kagehiro et al.	382/182
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.